Se	arch i	Notes	

Application/Control No.	Applicant(s)/Pate Reexamination	nt under
10/082,211	ONISHI ET AL.	
Examiner	Art Unit	
Karin M. Reichle	3761	

	SEAR	CHED	
Class	Subclass	Date	Examiner
updated	6/15/05 search	5/12/2006	KMR
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INT	ERFERENC	E SEARCH	IED
Class	Subclass	Date	Examiner
			

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
updated Inventor name search and EAST search-copies attached	5/12/2006	KMR